

Amendments to the Specification

Please amend the specification as follows:

Please replace the paragraph at page 7, lines 17-19 (paragraph 0058 of U.S. Patent Publication 2004/0027938), with the following replacement paragraph:

As described hereinafter in detail, the recording characteristic analyzing unit 5 can measure each ~~characteristics~~ characteristic corresponding to each of the parameters ~~in two~~ by two different methods.

Please replace the paragraph at page ¹²9, lines ²²⁻²⁴~~23-25~~ (paragraph 0076 of U.S. Patent Publication 2004/0027938), with the following replacement paragraph:

In addition, as understood from FIG. 3, a position at which the β (beta) value is maximized and that at which the spherical aberration is approximately minimized substantially ~~coincides~~ coincide with each other.

Please replace the paragraph at page 9, lines 21-25 (paragraph 0069 of U.S. Patent Publication 2004/0027938), with the following replacement paragraph:

In each of the signals S5, a level corresponding to the top pulse Tp of the recording pulse RP shown in FIG. 3C becomes a write level Lw, a level corresponding to the multi pulses Mp of the recording pulse RP shown in FIG. 3C becomes a pit level Lp, and a ~~level~~ level corresponding to the bias level B of the recording pulse RP shown in FIG. 3C becomes a read level Lr.